

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/601,138	MARKLING ET AL.	
		Examiner	Art Unit	
		Hanh V. Tran	3637	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2004/0159266	08-2004	Fisch et al.	108/057.25
	B	US-2003/0136314	07-2003	Smyers et al.	108/57.26
	C	US-2003/0019403	01-2003	Gruber et al.	108/53.1
	D	US-2001/0029874	10-2001	Muirhead, Scott Arthur William	108/57.25
	E	US-6,112,672	09-2000	Heil, Julius F.	108/55.3
	F	US-5,964,162	10-1999	Chuan-Jen, Hsieh	108/57.28
	G	US-5,794,544	08-1998	Shuert, Lyle H.	108/57.25
	H	US-5,470,641	11-1995	Shuert, Lyle H.	108/901
	I	US-5,401,347	03-1995	Shuert, Lyle H.	108/901
	J	US-3,720,176	03-1973	Munroe, Thomas	108/57.25
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	2224993	05-1990	Great Britain	Mead	108/901
	O	2002145265	05-2002	Japan	Mori	
	P	10236478	09-1998	Japan	Miyata et al	
	Q	07108512	04-1995	Japan	Kusatake	
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.